PETRA IV Workshop - Earth, Environment, and Materials for Nanoscience and Information Technology



Contribution ID: 50 Type: not specified

Using X-rays as in situ and in operando probe of semiconductor nanostructures

Wednesday 4 November 2020 10:55 (20 minutes)

Presenter: WALLENTIN, Jesper (Lund)

Session Classification: Structure of Nanomaterials and Nanoparticles during growth, in-situ and

operando conditions